

Search Notes

Application/Control No.

10/014,416

Examiner

Thomas D. Lee

Applicant(s)/Patent under
Reexamination

MATSUYA, AKIHIRO

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner
358	1.9, 504, 500, 515, 530	11/14/2005	TDL
382	162	11/14/2005	TDL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR